

OptiMOS®-T2 Power-Transistor





Features

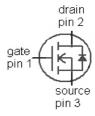
- N-channel Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

Product Summary

V _{DS}	40	V
R _{DS(on),max} (SMD version)	1.5	mΩ
I _D	120	Α

PG-TO263-3-2 PG-TO262-3-1 PG-TO220-3-1

Туре	Package	Marking
IPB120N04S4-01	PG-TO263-3-2	4N0401
IPI120N04S4-01	PG-TO262-3-1	4N0401
IPP120N04S4-01	PG-TO220-3-1	4N0401



Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ¹⁾	I _D	T _C =25°C, V _{GS} =10V	120	Α
		$T_{\rm C}$ =100°C, $V_{\rm GS}$ =10 $V^{2)}$	120	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25°C	480	
Avalanche energy, single pulse ²⁾	E _{AS}	I _D =60A	750	mJ
Avalanche current, single pulse	I _{AS}	-	120	Α
Gate source voltage	V_{GS}	-	±20	V
Power dissipation	P _{tot}	T _C =25°C	188	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



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Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics ²⁾						
Thermal resistance, junction - case	R _{thJC}	-	-	-	0.8	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}	-	-	-	62	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	
		6 cm ² cooling area ³⁾	-	-	40	

Electrical characteristics, at $T_{\rm j}$ =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{\rm GS}$ =0V, $I_{\rm D}$ = 1mA	40	1	ı	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 140 \mu {\rm A}$	2.0	3.0	4.0	
Zero gate voltage drain current	IDSS	V _{DS} =40V, V _{GS} =0V	1	0.06	1	μΑ
		$V_{\rm DS}$ =18V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =85°C ²⁾	1	1	20	
Gate-source leakage current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10V, I _D =100A	-	1.70	1.9	mΩ
		V _{GS} =10V, I _D =100A, SMD version	-	1.35	1.5	

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Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics ²⁾						
Input capacitance	C iss		-	10770	14000	pF
Output capacitance	C oss	$V_{\rm GS}$ =0V, $V_{\rm DS}$ =25V, f=1MHz	-	2450	3150	
Reverse transfer capacitance	C _{rss}		-	82	189	
Turn-on delay time	$t_{d(on)}$		-	34	-	ns
Rise time	tr	V _{DD} =20V, V _{GS} =10V,	-	16	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =120A, $R_{\rm G}$ =3.5 Ω	-	41	-	
Fall time	$t_{\rm f}$		-	36	-	
Gate Charge Characteristics ²⁾						
Gate to source charge	Q _{gs}		-	57	74	nC
Gate to drain charge	Q_{gd}	V _{DD} =32V, I _D =120A,	-	18	41	
Gate charge total	Q _g	V _{GS} =0 to 10V	-	135	176	
Gate plateau voltage	$V_{\rm plateau}$		-	5.3	-	V
Reverse Diode						
Diode continous forward current ²⁾	Is	- T _C =25°C	-	-	120	А
Diode pulse current ²⁾	I _{S,pulse}	7 c-23 O	-	-	480	
Diode forward voltage	V _{SD}	V _{GS} =0V, / _F =100A, T _j =25°C	-	0.9	1.3	V
Reverse recovery time ²⁾	t _{rr}	V_R =20V, I_F =50A, di_F/dt =100A/ μ s	-	64	-	ns
Reverse recovery charge ²⁾	Q _{rr}		-	88	-	nC

 $^{^{1)}}$ Current is limited by bondwire; with an $R_{\rm thJC}$ = 0.8K/W the chip is able to carry 266A at 25°C.

²⁾ Defined by design. Not subject to production test.

 $^{^{3)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm 2 (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.



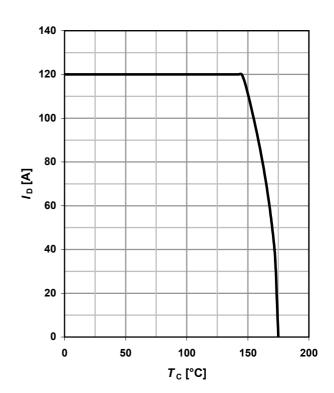
1 Power dissipation

$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$

200 175 150 125 P_{tot} [W] 100 75 50 25 0 0 50 100 200 150 *T*_c [°C]

2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}; \text{SMD}$$



3 Safe operating area

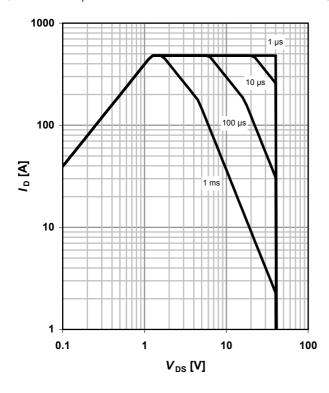
$$I_D = f(V_{DS}); T_C = 25 \,^{\circ}\text{C}; D = 0; \text{SMD}$$

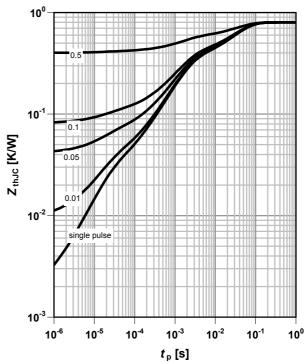
parameter: t_p

4 Max. transient thermal impedance

$$Z_{\rm thJC} = f(t_{\rm p})$$

parameter: $D = t_p/T$







5 Typ. output characteristics

 $I_D = f(V_{DS}); T_i = 25 \text{ °C}; SMD$

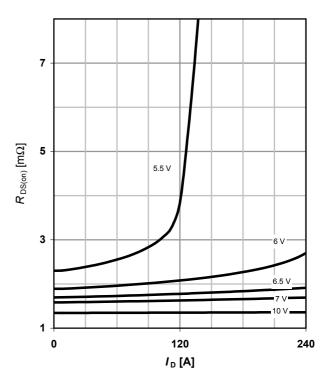
parameter: $V_{\rm GS}$

480 420 360 300 60 120 60 0 0 1 2 3 4 V_{DS} [V]

6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}; SMD$

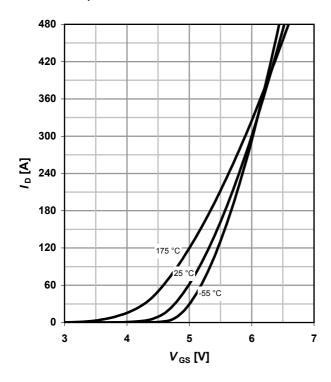
parameter: $V_{\rm GS}$



7 Typ. transfer characteristics

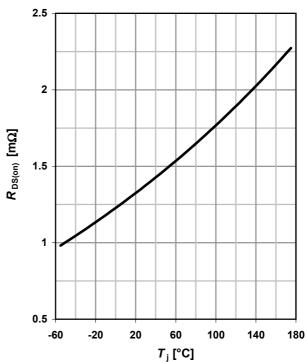
 $I_D = f(V_{GS}); V_{DS} = 6V$

parameter: T_i



8 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j); I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}; \text{SMD}$





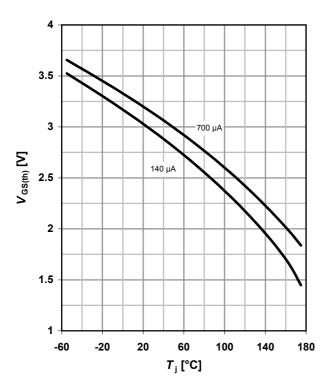
9 Typ. gate threshold voltage

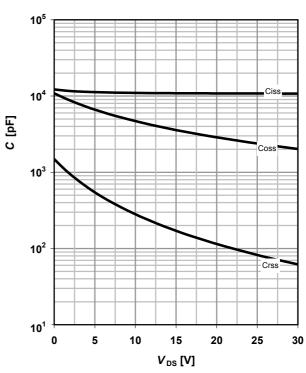
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D

10 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$





11 Typical forward diode characteristicis

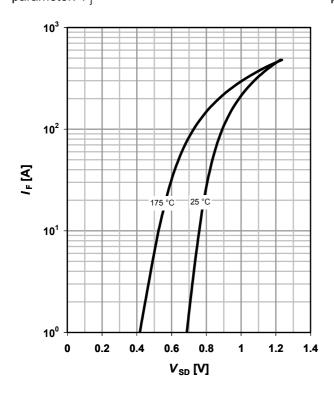
 $IF = f(V_{SD})$

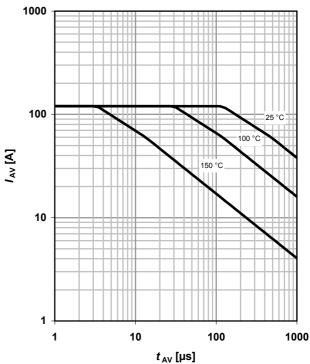
parameter: T_i

12 Avalanche characteristics

 $I_{AS} = f(t_{AV})$

parameter: T_{j(start)}







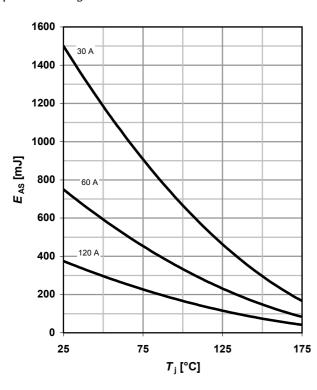
13 Avalanche energy

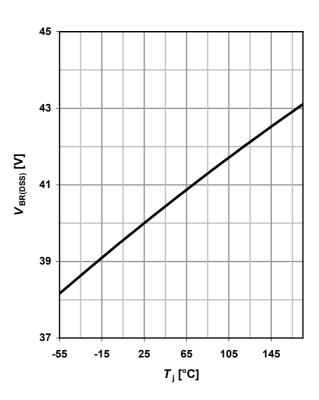
$E_{AS} = f(T_i)$

parameter: I_D

14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_i); I_D = 1 \text{ mA}$$

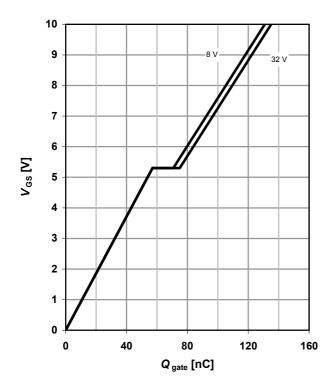




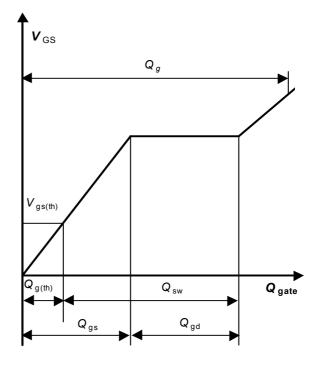
15 Typ. gate charge

 $V_{\rm GS}$ = f($Q_{\rm gate}$); $I_{\rm D}$ = 120 A pulsed

parameter: V_{DD}



16 Gate charge waveforms





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IPB120N04S4-01 IPI120N04S4-01, IPP120N04S4-01

Revision History

Version	Date		Changes
Revision 1.0		12.04.2010	Final Data Sheet